S	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/756,478	STAMLER ET AL.	
Examiner	Art Unit	
B. Dell Chism	1654	

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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB text search	See interference Search Printout	02-06-06	BDC

SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	<b>'</b> )
	DATE	EXMR
STN WEST (514/6; text) Inventors Search	2/6/2006	BDC